Dual N-Channel PowerTrench® MOSFET

30 V, 28 A, 2.12 m Ω

General Description

This package integrates two N-Channel devices connected internally in common-source configuration. This enables very low package parasitics and optimized thermal path to the common source pad on the bottom. Provides a very small footprint (3.3 x 5 mm) for higher power density.

Features

- Max $r_{DS(on)} = 2.12 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 28 \text{ A}$
- Max $r_{DS(on)} = 2.95 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 24 \text{ A}$
- Ideal for Flexible Layout in Secondary Side Synchronous Rectification
- 100% UIL Tested
- Termination is Lead-free and RoHS Compliant

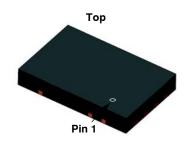
Applications

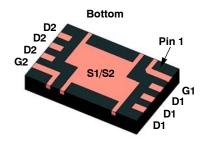
- Isolated DC-DC Synchronous Rectifiers
- Common Ground Load Switches



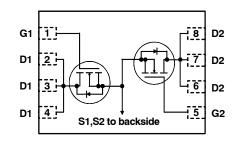
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PQFN8 PowerTrench CASE 483AU



ORDERING INFORMATION

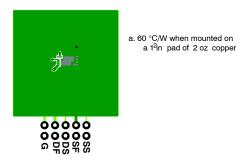
See detailed ordering and shipping information on page 2 of this data sheet.

Table 1. MOSFET MAXIMUM RATINGS $T_A = 25^{\circ}C$ unless otherwise noted.

Symbol	Parameter		Rating	Units	
V _{DS}	Drain to Source Voltage		30	V	
V _{GS}	Gate to Source Voltage		±20	V	
I _D	Drain Current -Continuous	T _C = 25°C (Note 1)	95	А	
	- Continuous	T _C = 100°C (Note 1)	60		
	- Continuous	T _A = 25°C (Figure 1)	28		
	- Pulsed	(Note 2)	562		
E _{AS}	Single Pulse Avalanche Energy	(Note 3)	96	mJ	
P_{D}	Power Dissipation	T _C = 25°C	29	W	
	Power Dissipation	T _A = 25°C (Figure 1)	2.1		
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electromechanical application board design.
- 2. Pulse Id refers to Figure 13 Forward Bias Safe Operating Area.
- 3. E_{AS} of 96 mJ is based on starting $T_J = 25$ °C; L = 0.3 mH, $I_{AS} = 31.7$ A, $V_{DD} = 27$ V.





b.160 °C/W when mounted on a minimum pad of 2 oz copper

Figure 1.

Figure 2.

Table 2. THERMAL CHARACTERISTICS

$R_{ heta JC}$	Thermal Resistance, Junction to Case	4.7	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Figure 1)	60	

R_{θJA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material, R_{θCA} is determined by the user's board design.

Table 3. PACKAGE MARKING AND ORDERING INFORMATION

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMD8430	FDMD8430	Power 3.3 x 5	13″	12 mm	3000 units

Table 4. ELECTRICAL CHARACTERISTICS T_J = 25°C unless otherwise noted.

Symbol	Parameter	Test Cor	nditions	Min	Тур	Max	Units
OFF CHARA	ACTERISTICS	•					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$		30			V
$\Delta BV_{DSS/} \over \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu A$, referenced to 25°C			17		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 24 V, V _{GS} = 0	V			1	μА
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} =$	0 V			±100	nA
ON CHARA	CTERISTICS						
V _{GS(th)}	Gate to Source Threshold Voltage	V _{GS} = V _{DS} , I _D = 250	μΑ	1.0	1.6	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I _D = 250 μA, reference	ced to 25°C		-5		mV/°C
r _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 28 A	V _{GS} = 10 V, I _D = 28 A		1.5	2.12	mΩ
		$V_{GS} = 4.5 \text{ V}, I_D = 24$	A		2.0	2.95	1
		V _{GS} = 10 V, I _D = 28 A, T _J = 125°C			1.7	2.4	1
9FS	Forward Transconductance	V _{DD} = 5 V, I _D = 28 A				250	S
DYNAMIC C	CHARACTERISTICS						
C _{iss}	Input Capacitance	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHZ			3595	5035	pF
C _{oss}	Output Capacitance				1150	1610	pF
C _{rss}	Reverse Transfer Capacitance				112	160	pF
R_{g}	Gate Resistance				2.3	4.5	Ω
SWITCHING	CHARACTERISTICS						
t _{d(on)}	Turn-On Delay Time	V _{DD} = 15 V, I _D = 28 A	Α,		11	20	ns
t _r	Rise Time	V _{GS} = 10 V, R _{GEN} =	6 Ω		8	16	ns
t _{d(off)}	Turn-Off Delay Time				71	114	ns
t _f	Fall Time				20	36	ns
Q _{g(tot)}	Total Gate Charge	V _{GS} = 0 V to 10 V	V _{DD} = 15 V,		52	90	nC
	Total Gate Charge	V _{GS} = 0 V to 4.5 V	I _D = 28 A		25	45	nC
Q _{gs}	Gate to Source Charge		•		10		nC
Q _{gd}	Gate to Drain "Miller" Charge				7		nC
DRAIN-SOL	JRCE DIODE CHARACTERISTICS	<u>.</u>		-			
V _{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _S = 28 A	(Note 5)		8.0	1.2	V
t _{rr}	Reverse Recovery Time	I _F = 28 A, di/dt = 100) A/μs		40	64	ns
	Reverse Recovery Charge				22		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulse Test: Pulse Width < 300 μs, Duty Cycle < 2.0%.

TYPICAL CHARACTERISTICS $T_J = 25^{\circ}C$ unless otherwise noted.

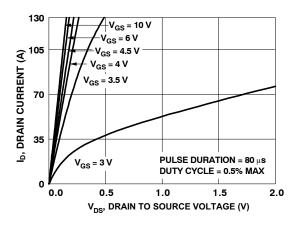


Figure 3. On Region Characteristics

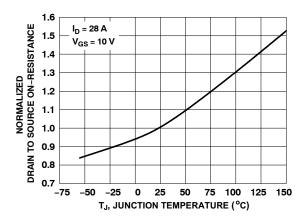


Figure 5. Normalized On-Resistance vs. Junction Temperature

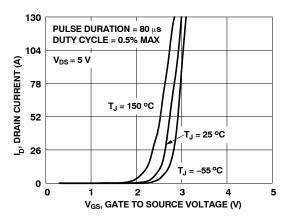


Figure 7. Transfer Characteristics

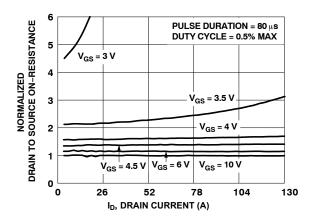


Figure 4. Normalized On–Resistance vs. Drain Current and Gate Voltage

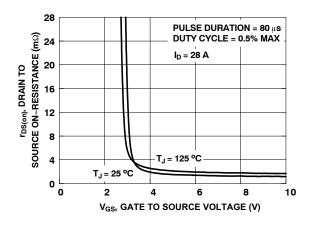


Figure 6. On-Resistance vs. Gate to Source Voltage

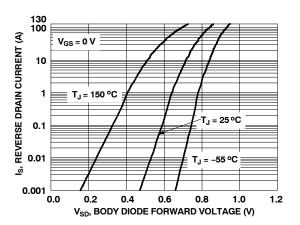


Figure 8. Source to Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS $T_J = 25^{\circ}C$ unless otherwise noted.

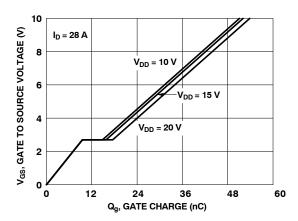


Figure 9. Gate Charge Characteristics

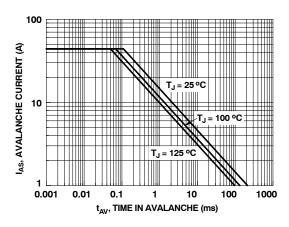


Figure 11. Unclamped Inductive Switching Capability

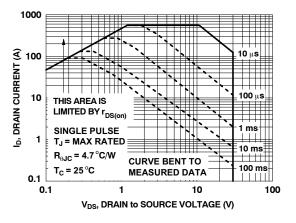


Figure 13. Forward Bias Safe Operating Area

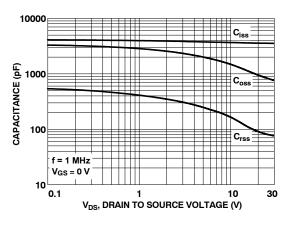


Figure 10. Capacitance vs. Drain to Source Voltage

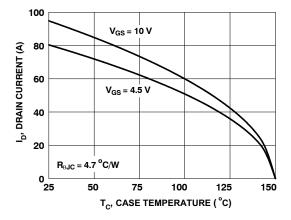


Figure 12. Maximum Continuous Drain Current vs. Case Temperature

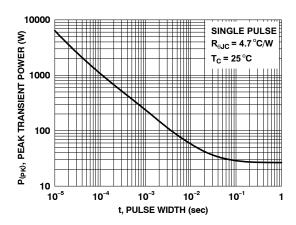


Figure 14. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS $T_J = 25^{\circ}\text{C}$ unless otherwise noted.

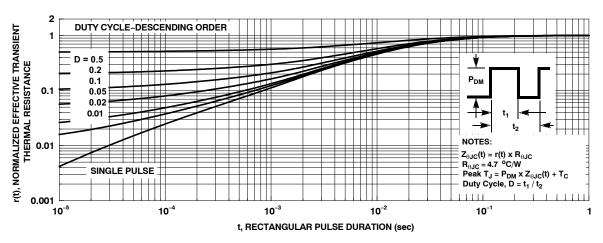


Figure 15. Junction-to-Case Transient Thermal Response Curve





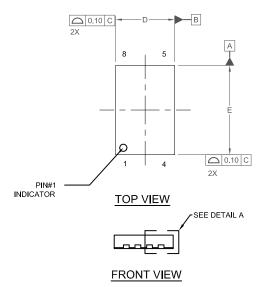


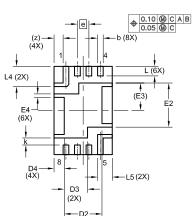
PQFN8 3.30x5.00x0.75, 0.65P CASE 483AU **ISSUE B**

// 0.10 C

0.08 C

DATE 19 APR 2024





C A1-(A3) SEATING PLANE DETAIL A SCALE: 2X 1 95 → 0.97 0.65 TYP KEEP OUT AREA 0.42 (8X) -0.30 0.70 (6X) 5.22 2 60 3.22 2.60 1.61 1.30 (2X) 1.12

RECOMMENDED LAND PAD

(3.40)

1 34 -224→

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NOTES: UNLESS OTHERWISE SPECIFIED A) DOES NOT FULLY CONFORM TO JEDEC REGISTRATION, MO229 DATED 8/2012. B) ALL DIMENSIONS ARE IN MILLIMETERS.

- C) DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH. MOLD FLASH OR BURRS DOES NOT EXCEED 0.10MM.
- D) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.
- E) IT IS RECOMMENDED TO HAVE NO TRACES OR VIAS WITHIN THE KEEP OUT AREA.

DIM	MILLIMETERS				
Dilvi	MIN.	NOM.	MAX.		
Α	0.70	0.75	0.80		
A1	0.00	1	0.05		
А3	C).20 REF			
b	0.27	0.32	0.37		
D	3.20	3.30	3.40		
D2	2.04	2.14	2.24		
D3	1.22	1.32	1.42		
D4	0.48	0.58	0.68		
Ш	4.90	5.00	5.10		
E2	2.40	2.50	2.60		
E3	1	.56 REF			
E4	0.10	0.20	0.30		
е	0.65 BSC				
k	0.30	0.40	0.50		
L	0.44	0.54	0.64		
L4	1.04	1.14	1.24		
L5	0.75 0.85 0.95		0.95		
Z	0.51 REF				

BOTTOM VIEW

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